



Using IPC/JEDEC-9704 & 9702 Standards for Strain Gage Testing of Printed Wiring Boards

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Agenda

- Problem Statement
- Solution
- How to Implement a Strain Gage Test
- Strain Gage Tests at National Instruments
- Conclusion





Conference & exhibition

Problem Statement

- PCB failures due of over-flexure during various assembly and test processes
- Partial cracks
- Field returns





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Trends: Finer Pitch BGAs



Before

Common Pitch: 1.27 mm, 1 mm



Today

Common Pitch: 0.8 mm, 0.5 mm





Trends: Lead-free solder









Trends: PCB Thickness



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The Effect

BGA with RoHS compliant solder

Outer rows do not distribute as much stress to the adjacent rows

Thin PCBs bend more

Solution: Strain Gage Testing (SGT)

- Identify and correct problem processes
 - Assembly
 - Test

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Problem Processes

• In Circuit Tests

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Problem Processes

• De-panelizing (manual)

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Problem Processes

• Edge cutting machines

Problem Processes

• FVT

Solution: Strain Gage Testing (SGT)

Correct problem processes

BGA With Strain Gages

To Data Acquisition System **Rosette** Strain Gages **BGA**

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Who should be concerned

Test-fixture vendors

Contract manufacturers

PCB assemblers

Component suppliers

IPC/JEDEC Standards

• IPC/JEDEC 9704

– Printed Wiring Board Strain Gage Test Guideline

• IPC/JEDEC 9702

 Monotonic Bend Characterization of Board-Level Interconnects

Industry involvement

- Intel
- Cisco Systems
- Sun Microsystems
- Solectron

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Circuit Check

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IPC/JEDEC 9704

- Recommended strain gages
- Gage placement and attachment
- Measurement equipment
- Data analysis
- Reporting Template

SGT System I/O Requirements

- Hardware
 - Sampling rate of 2KHz
 - At least 3 channels (12 or more recommended)
 - Simultaneous sampling of all channels
 - 12 to 16 bit input resolution
 - Low-pass filter
 - Gain
- Software
 - User Interface
 - Reporting

Components of a SGT

- Sensor
 - Rosette strain gages
- Signal Conditioning
- Data Acquisition
- Software
- Reporting

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Sensor

• Stacked Rosette Strain Gages with pre-attached wires

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Data Acquisition

Sampling Rate

Number of Channels

• Simultaneous Sampling

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Software

• User Interface

onfigure Hardware	View Curre	ent Test		Quit Pro	gram
Input Device(s)	cDAO Devices		Sampling/Test	t Setup	
Number of Rosettes	% cDAQ1Mod1 % cDAQ1Mod2 % cDAQ1Mod2 % cDAQ1Mod3	V V	Maximum Input Minimum Input Sampling Rate	0.0010 -0.0010 2000	Strain Strain Hz
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Software

• Analysis

Diagonal strain = e1-e2+e3

Reporting

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5	Inspector:		-				*10^6 in/n	*10^6 irvin	*10^-6 in/n	*10^6 in/n	*10^6 in/n	
	Date:	4/5/2007	-	1	Strain Gauge 1	Upper Left	-2179	-2310	-2371	2240	2310	
<u></u>	Part Number:		-	2	Strain Gauge 2	Upper Right	-2245	•11/7	-1814	2002	2662	
2	Serial Number:		_	3	Strain Gauge 3	Lower Left	-2321	-2200	-2398	2519	2519	
	CTRAIN MEACHDEMENT	FOURDMENT	-	4	Strain Gauge 4	Lower Right	•2334	-2435	•2353	2252	2435	-
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1	Signal Conditioning 7:	NI 9237	-	-								
5	Signal Conditioning 2:	NI 9237	-	-								
3	Sampling Rate	2000	-	-								
4				-								
5	STRAIN GAGES			-								
8	Part number:			-					-			
7	Manufacturer:		-									
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Results at National Instruments:

- Effectively use Strain Gage Testing for correcting ICT fixtures
 - Virtual Instrumentation solution
 - Flexible Software
 - Modular Hardware

Solutions Used by NI

NI CompactDAQ

Up to 32 simultaneous strain channels

NI SCXI

>32 simultaneous strain channels

Conclusion

- Critical to be Lead-free and RoHS compliant
- Adoption of strain gage testing for better PCB assembly yields

Thank you

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